

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/517,517	DEMMELER ET AL.
	Examiner Seung H. Lee	Art Unit 2887

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner
Same as	Above	1/18/2008	SL